

## A

- Aleksenko N.G.** – See Khmil D.N., Kamuz A.M., Oleksenko P.F., Kamuz V.G., Kamuz O.A.; **18(2)**, 215-219.
- Aleksenko N.G.** – See Khmil' D.N., Kamuz A.M., Oleksenko P.F., Kamuz V.G., Kamuz O.A.; **18(3)**, 333-340.
- Arsentiev I.N.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(3)**, 317-323.
- Ataubaeva A.B.** – See Nasyrov M.U.; **18(2)**, 220-225.
- Avksentyev A.Yu.** – See Naumov A.V., Kolomys O.F., Romanyuk A.S., Tsykaniuk B.I., Strelchuk V.V., Trius M.P., Belyaev A.E.; **18(4)**, 396-402.
- Azhniuk Yu.M.** – Annealing-induced formation of  $\text{Sn}_2\text{P}_2\text{S}_6$  crystallites in  $\text{As}_2\text{S}_3$ -based glass matrix – Gomonnai A.V., Gomonnai O.O., Hasynets S.M., Kováč F., Lopushansky V.V., Petryshynets I., Rubish V.M., Zahn D.R.T.; **18(3)**, 248-254.

## B

- Bacherikov Yu.Yu.** – Effect of heating rate on oxidation process of fine-dispersed ZnS:Mn obtained by SHS – Zhuk A.G., Okhrimenko O.B., Kardashov D.L., Kozitskiy S.V., Kidalov V.V.; **18(2)**, 226-229.
- Bacherikov Yu.Yu.** – Electroluminescence powdered ZnS:Cu obtained by one-stage synthesis – Zhuk A.G., Okhrimenko O.B., Kardashov D.L., Kozitskiy S.V.; **18(3)**, 309-311.
- Basiuk E.V.** – See Dmitruk N.L., Borkovskaya O.Yu., Mamykin S.V., Havrylenko T.S., Mamontova I.B., Kotova N.V.; **18(1)**, 31-35.
- Baturin V.A.** – See Myroniuk D.V., Ievtushenko A.I., Lashkarev G.V., Maslyuk V.T., Timofeeva I.I., Karpenko O.Y., Kuznetsov V.M., Dranchuk M.V.; **18(3)**, 286-291.
- Belyaev A.E.** – Ohmic contacts based on Pd to indium phosphide Gunn diodes – Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(3)**, 317-323.
- Belyaev A.E.** – See Naumov A.V., Kolomys O.F., Romanyuk A.S., Tsykaniuk B.I., Strelchuk V.V., Trius M.P., Avksentyev A.Yu.; **18(4)**, 396-402.
- Belyaev A.E.** – Structural and electrical-physical properties of the ohmic contacts based on palladium to  $n^+-n^{++}-n^{+++}$ -InP – Boltovets N.A., Bobyl A.B., Kladko V.P., Konakova R.V., Kudryk Ya.Ya., Nasyrov M.U., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(4)**, 391-395.
- Bendak A.V.** – See Studenyak I.P., Demko P.Yu., Kovalchuk O.V., Kovalchuk T.M., Lisý V., Kopčanský P., Timko M., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Lad A.I., Kucheriavchenkova N.M.; **18(2)**, 205-208.
- Bletskan D.I.** – See Bletskan M.M., Kabatsii V.M.; **18(1)**, 12-19.
- Bletskan M.M.** – Electronic structure of  $\text{PbSnS}_3$  and  $\text{PbGeS}_3$  semiconductor compounds with the mixed cation coordination – Bletskan D.I., Kabatsii V.M.; **18(1)**, 12-19.
- Bobrenko Yu.N.** – Thin-film solar converters based on the p- $\text{Cu}_{1.8}\text{S}/n\text{-CdTe}$  surface-barrier structure – Pavelets S.Yu., Semikina T.V., Stadnyk O.A., Sheremetova G.I., Yaroshenko M.V.; **18(1)**, 101-105.
- Bobyk V.V.** – See Rudko G.Yu., Kovalenko S.A., Gule E.G., Solomakha V.M., Bogoslovskaya A.B.; **18(1)**, 20-25.
- Bobyl A.B.** – See Belyaev A.E., Boltovets N.A., Kladko V.P., Konakova R.V., Kudryk Ya.Ya., Nasyrov M.U., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(4)**, 391-395.
- Bobyl A.V.** – See Belyaev A.E., Boltovets N.S., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(3)**, 317-323.
- Bodnar G.B.** – See Ushenko Yu.O., Dubolazov O.V., Motrich A.V.; **18(2)**, 158-163.
- Bogoslovskaya A.B.** – See Rudko G.Yu., Kovalenko S.A., Gule E.G., Bobyk V.V., Solomakha V.M.; **18(1)**, 20-25.
- Bohdan R.** – See Neimet Yu.Yu., Studenyak I.P., Buchuk M.Yu., Kökényesi S., Daróci L., Nemes P.; **18(4)**, 385-390.
- Bohdan R.** – See Studenyak I.P., Kutsyk M.M., Rati Y.Y., Izai V.Yu., Kökényesi S., Daróci L.; **18(2)**, 188-192.
- Boiko I.I.** – Dependence of the collision integral on electric field; **18(2)**, 138-143.
- Boiko V.A.** – See Tetyorkin V.V., Sukach A.V., Tkachuk A.I.; **18(4)**, 428-432.
- Boltovets N.A.** – See Belyaev A.E., Bobyl A.B., Kladko V.P., Konakova R.V., Kudryk Ya.Ya., Nasyrov M.U., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(4)**, 391-395.

- Boltovets N.S.** – See Belyaev A.E., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(3)**, 317-323.
- Bondarenko V.O.** – See Markevich I.V., Stara T.R.; **18(2)**, 134-137.
- Bondarenko V.O.** – See Markevich I.V., Stara T.R.; **18(3)**, 344-348.
- Borkovskaya O.Yu.** – See Dmitruk N.L., Mamykin S.V., Havrylenko T.S., Mamontova I.B., Kotova N.V., Basiuk E.V.; **18(1)**, 31-35.
- Borodinova T.I.** – See Lopatynska O.G., Lopatynskiy A.M., Chegel V.I., Poperenko L.V.; **18(4)**, 410-415.
- Boyko I.V.** – See Gryshchuk A.M.; **18(2)**, 123-127.
- Boyko M.I.** – See Strelchuk V.V., Kolomys O.F., Golichenko B.O., Kaganovich E.B., Krishchenko I.M., Kravchenko S.O., Lytvyn O.S., Manoilov E.G., Nasieka Iu.M.; **18(1)**, 46-52.
- Bratus' V.Ya.** – Thermal annealing and evolution of defects in neutron-irradiated cubic SiC – Melnyk R.S., Shanina B.D., Okulov S.M.; **18(4)**, 403-409.
- Bricks J.L.** – See Grytsenko K.P., Lytvyn P.M., Doroshenko T.P., Kolomzarov Yu.V., Kurdyukov V., Slominskii Yu.L., Tolmachev O.I.; **18(4)**, 433-437.
- Buchuk M.Yu.** – See Neimet Yu.Yu., Studenyak I.P., Bohdan R., Kökényesi S., Daróci L., Nemeč P.; **18(4)**, 385-390.
- Burkovets D.M.** – See Dubolazov O.V., Olar O.I.; **18(2)**, 170-174.
- Burkovets D.M.** – See Ushenko A.G., Koval G.D., Savich V.O.; **18(2)**, 175-180.

## C

- Chegel V.I.** – Plasmon-enhanced fluorometry based on gold nanostructure arrays. Method and device – Lytvyn V.K., Lopatynskiy A.M., Shepeliavyi P.E., Lytvyn O.S., Goltvyanskiy Yu.V.; **18(3)**, 272-278.
- Chegel V.I.** – See Lopatynska O.G., Lopatynskiy A.M., Borodinova T.I., Poperenko L.V.; **18(4)**, 410-415.
- Chernenko V.V.** – See Kostylyov V.P., Sachenko A.V., Serba O.A., Slusar T.V., Vlasyuk V.M., Tytarenko P.O.; **18(4)**, 464-467.

## D

- Dan'ko V.A.** – Nanopatterning Au chips for SPR refractometer by using interference lithography and chalcogenide photoresist – Dorozinsky G.V., Indutnyi I.Z., Myn'ko V.I.,

Ushenin Yu.V., Shepeliavyi P.E., Lukaniuk M.V., Korchovyi A.A., Khrystosenko R.V.; **18(4)**, 438-442.

- Daróci L.** – See Neimet Yu.Yu., Studenyak I.P., Buchuk M.Yu., Bohdan R., Kökényesi S., Nemeč P.; **18(4)**, 385-390.
- Daróci L.** – See Studenyak I.P., Kutsyk M.M., Rati Y.Y., Izai V.Yu., Kökényesi S., Bohdan R.; **18(2)**, 188-192.
- Demko P.Yu.** – See Studenyak I.P., Bendak A.V., Kovalchuk O.V., Kovalchuk T.M., Lisý V., Kopčanský P., Timko M., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Lad A.I., Kucheriavchenkova N.M.; **18(2)**, 205-208.
- Derevyanchuk A.V.** – See Kondryuk D.V., Kramar V.M., Kudryavtsev A.A.; **18(2)**, 128-133.
- Dmitruk N.L.** – Au/GaAs photovoltaic structures with single-wall carbon nanotubes on the microrelief interface – Borkovskaya O.Yu., Mamykin S.V., Havrylenko T.S., Mamontova I.B., Kotova N.V., Basiuk E.V.; **18(1)**, 31-35.
- Dobrovolsky Yu.** – Thermostabilized photodiode for monitoring radiation of medical lasers – Pidkamin L., Kuzenko V.; **18(4)**, 443-447.
- Dominikov M.M.** – See Ushenko A.G., Lakusta I.I., Koval G.D.; **18(2)**, 164-169.
- Doroshenko T.P.** – See Grytsenko K.P., Lytvyn P.M., Kolomzarov Yu.V., Bricks J.L., Kurdyukov V., Slominskii Yu.L., Tolmachev O.I.; **18(4)**, 433-437.
- Dorozinsky G.V.** – See Dan'ko V.A., Indutnyi I.Z., Myn'ko V.I., Ushenin Yu.V., Shepeliavyi P.E., Lukaniuk M.V., Korchovyi A.A., Khrystosenko R.V.; **18(4)**, 438-442.
- Dranchuk M.V.** – See Myroniuk D.V., Ievtushenko A.I., Lashkarev G.V., Maslyuk V.T., Timofeeva I.I., Baturin V.A., Karpenko O.Y., Kuznetsov V.M.; **18(3)**, 286-291.
- Dub M.N.** – See Slipokurov V.S., Tkachenko A.K., Kudryk Ya.Ya.; **18(2)**, 144-146.
- Dubolazov O.V.** – Multifunctional polarization tomography of birefringence networks of biological crystals – Olar O.I., Burkovets D.M.; **18(2)**, 170-174.
- Dubolazov O.V.** – See Ushenko Yu.O., Motrich A.V., Bodnar G.B.; **18(2)**, 158-163.
- Dubolazov O.V.** – Statistical and fractal analyses of autofluorescence of myocardium tissue images in diagnostics of acute coronary insufficiency – Sidor M.I., Karachevtsev A.O.; **18(2)**, 152-157.
- Dubyna D.S.** – See Shapovalov A.P., Korotash I.V., Rudenko E.M., Sizov F.F., Osipov L.S., Polotskiy D.Yu., Tsybrii Z.F., Korchovyi A.A.; **18(2)**, 117-122.
- Dukhnin S.E.** – See Shevchik-Shekera A.V.; **18(3)**, 341-343.

## F

- Fediv V.I.** – See Kovalchuk A.O., Rudko G.Yu., Gule E.G.; **18**(1), 74-78.  
**Fomin A.V.** – See Pashchenko G.A., Kravetskyi M.Yu.; **18**(3), 330-332.

## G

- Gaidar G.P.** – Changes in electrophysical properties of heavily doped n-Ge ⟨As⟩ single crystals under the influence of thermoannealings; **18**(1), 53-56.  
**Galkin S.N.** – See Stanetska A.S., Tomashyk V.N., Stratiychuk I.B., Tomashyk Z.F., Kravetskyi M.Yu.; **18**(4), 416-421.  
**Gdovinova V.** – See Studenyak I.P., Demko P.Yu., Bendak A.V., Kovalchuk O.V., Kovalchuk T.M., Lisý V., Kopčanský P., Timko M., Tomašovičová N., Zavisova V., Miskuf J., Oleinikova I.V., Lad A.I., Kucheriavchenkova N.M.; **18**(2), 205-208.  
**Golenkov A.G.** – Sub-THz nonresonant detection in AlGaIn/GaN heterojunction FETs – Zhuravlev K.S., Gumenjuk-Sichevska J.V., Lysiuk I.O., Sizov F.F.; **18**(1), 40-45.  
**Golichenko B.O.** – See Strelchuk V.V., Kolomys O.F., Boyko M.I., Kaganovich E.B., Krishchenko I.M., Kravchenko S.O., Lytvyn O.S., Manoilov E.G., Nasieka Iu.M.; **18**(1), 46-52.  
**Goltvyanskyi Yu.V.** – See Chegel V.I., Lytvyn V.K., Lopatynskyi A.M., Shepeliavyi P.E., Lytvyn O.S.; **18**(3), 272-278.  
**Gomonnai A.V.** – See Azhniuk Yu.M., Gomonnai O.O., Hasynets S.M., Kováč F., Lopushansky V.V., Petryshynets I., Rubish V.M., Zahn D.R.T.; **18**(3), 248-254.  
**Gomonnai O.O.** – See Azhniuk Yu.M., Gomonnai A.V., Hasynets S.M., Kováč F., Lopushansky V.V., Petryshynets I., Rubish V.M., Zahn D.R.T.; **18**(3), 248-254.  
**Grygorchak I.I.** – See Ivashchyshyn F.O., Klapchuk M.I.; **18**(3), 362-366.  
**Gryschuk A.M.** – Influence of dimensional static and dynamic charges on conduction in the active zone of a quantum cascade laser – Boyko I.V.; **18**(2), 123-127.  
**Grytsenko K.P.** – Morphology of sulphur-terminated compound deposits condensed on different substrates in vacuum – Lytvyn P.M., Doroshenko T.P., Kolomzarov Yu.V., Bricks J.L., Kurdyukov V., Slominskii Yu.L., Tolmachev O.I.; **18**(4), 433-437.  
**Gudymenko A.I.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Shynkarenko V.V.; **18**(3), 317-323.

- Gudymenko A.I.** – See Belyaev A.E., Boltovets N.A., Bobyl A.B., Kladko V.P., Konakova R.V., Kudryk Ya.Ya., Nasyrov M.U., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Shynkarenko V.V.; **18**(4), 391-395.  
**Gule E.G.** – See Kovalchuk A.O., Rudko G.Yu., Fediv V.I.; **18**(1), 74-78.  
**Gule E.G.** – See Rudko G.Yu., Kovalenko S.A., Bobyk V.V., Solomakha V.M., Bogoslovskaya A.B.; **18**(1), 20-25.  
**Gumenjuk-Sichevska J.V.** – See Golenkov A.G., Zhuravlev K.S., Lysiuk I.O., Sizov F.F.; **18**(1), 40-45.  
**Gumenjuk-Sichevska J.V.** – See Melezhik E.O., Sizov F.F.; **18**(3), 297-301.  
**Gutsul V.I.** – See Makhnats O.M., Kuchak A.I., Voitsekhivska O.M.; **18**(1), 57-62.

## H

- Hasynets S.M.** – See Azhniuk Yu.M., Gomonnai A.V., Gomonnai O.O., Kováč F., Lopushansky V.V., Petryshynets I., Rubish V.M., Zahn D.R.T.; **18**(3), 248-254.  
**Havrylenko T.S.** – See Dmitruk N.L., Borkovskaya O.Yu., Mamykin S.V., Mamontova I.B., Kotova N.V., Basiuk E.V.; **18**(1), 31-35.

## I

- Ievtushenko A.I.** – See Myroniuk D.V., Lashkarev G.V., Maslyuk V.T., Timofeeva I.I., Baturin V.A., Karpenko O.Y., Kuznetsov V.M., Dranchuk M.V.; **18**(3), 286-291.  
**Indutnyi I.Z.** – See Dan'ko V.A., Dorozinsky G.V., Myn'ko V.I., Ushenin Yu.V., Shepeliavyi P.E., Lukaniuk M.V., Korchovyi A.A., Khrystosenko R.V.; **18**(4), 438-442.  
**Indutnyi I.Z.** – See Michailovska K.V., Kudryavtsev O.O., Sopinsky M.V., Shepeliavyi P.E.; **18**(3), 324-329.  
**Ishikawa Y.** – See Vasin A.V., Rusavsky A.V., Nazarov A.N., Konchitz A.A., Lysenko V.S.; **18**(1), 63-70.  
**Ivashchyshyn F.O.** – Impedance anisotropy and quantum photocapacity of bio/inorganic clathrates InSe⟨histidine⟩ and GaSe⟨histidine⟩ – Grygorchak I.I., Klapchuk M.I.; **18**(3), 362-366.  
**Izai V.Yu.** – See Studenyak I.P., Kutsyk M.M., Rati Y.Y., Kökényesi S., Daróci L., Bohdan R.; **18**(2), 188-192.

## K

- Kabatsii V.M.** – See Bletska M.M., Bletska D.I.; **18**(1), 12-19.

- Kaganovich E.B.** – See Strelchuk V.V., Kolomys O.F., Golichenko B.O., Boyko M.I., Krishchenko I.M., Kravchenko S.O., Lytvyn O.S., Manoilov E.G., Nasieka Iu.M.; **18**(1), 46-52.
- Kamuz A.M.** – See Khmil D.N., Oleksenko P.F., Kamuz V.G., Aleksenko N.G., Kamuz O.A.; **18**(2), 215-219.
- Kamuz A.M.** – See Khmil' D.N., Oleksenko P.F., Kamuz V.G., Aleksenko N.G., Kamuz O.A.; **18**(3), 333-340.
- Kamuz O.A.** – See Khmil D.N., Kamuz A.M., Oleksenko P.F., Kamuz V.G., Aleksenko N.G.; **18**(2), 215-219.
- Kamuz O.A.** – See Khmil' D.N., Kamuz A.M., Oleksenko P.F., Kamuz V.G., Aleksenko N.G.; **18**(3), 333-340.
- Kamuz V.G.** – See Khmil D.N., Kamuz A.M., Oleksenko P.F., Aleksenko N.G., Kamuz O.A.; **18**(2), 215-219.
- Kamuz V.G.** – See Khmil' D.N., Kamuz A.M., Oleksenko P.F., Aleksenko N.G., Kamuz O.A.; **18**(3), 333-340.
- Karachevtsev A.O.** – See Dubolazov O.V., Sidor M.I.; **18**(2), 152-157.
- Karachevtsev A.O.** – See Sidor M.I., Prysyzhnyuk V.P.; **18**(2), 147-151.
- Karachevtseva L.A.** – See Electro-optical effects in 2D macroporous silicon structures with nanocoatings – Lytvynenko O.O., Konin K.P., Parshyn K.A., Sapelnikova O.Yu., Stronska O.J.; **18**(4), 377-384.
- Kardashov D.L.** – See Bacherikov Yu.Yu., Zhuk A.G., Okhrimenko O.B., Kozitskiy S.V., Kidalov V.V.; **18**(2), 226-229.
- Kardashov D.L.** – See Bacherikov Yu.Yu., Zhuk A.G., Okhrimenko O.B., Kozitskiy S.V.; **18**(3), 309-311.
- Karpenko O.Y.** – See Myroniuk D.V., Ievtushenko A.I., Lashkarev G.V., Maslyuk V.T., Timofeeva I.I., Baturin V.A., Kuznetsov V.M., Dranchuk M.V.; **18**(3), 286-291.
- Khmil D.N.** – Method for determination of the absorption coefficient in films based on photoluminophore suspension for white LEDs – Kamuz A.M., Oleksenko P.F., Kamuz V.G., Aleksenko N.G., Kamuz O.A.; **18**(2), 215-219.
- Khmil' D.N.** – Determination of the spectral dependence for the absorption coefficient of phosphor inorganic microparticles – Kamuz A.M., Oleksenko P.F., Kamuz V.G., Aleksenko N.G., Kamuz O.A.; **18**(3), 333-340.
- Khomenko D.V.** – See Sachenko A.V., Kostylyov V.P., Korkishko R.M., Kulish M.R., Sokolovskyi I.O., Vlasiuk V.M.; **18**(3), 259-266.
- Khrystosenko R.V.** – Optimization of the surface plasmon resonance minimum detection algorithm for improvement of method sensitivity; **18**(3), 279-285.
- Khrystosenko R.V.** – See Dan'ko V.A., Dorozinsky G.V., Indutnyi I.Z., Myn'ko V.I., Ushenin Yu.V., Shepeliavyyi P.E., Lukaniuk M.V., Korchovyyi A.A.; **18**(4), 438-442.
- Kidalov V.V.** – See Bacherikov Yu.Yu., Zhuk A.G., Okhrimenko O.B., Kardashov D.L., Kozitskiy S.V.; **18**(2), 226-229.
- Kladko V.P.** – See Belyaev A.E., Boltovets N.A., Bobyl A.B., Konakova R.V., Kudryk Ya.Ya., Nasyrov M.U., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18**(4), 391-395.
- Kladko V.P.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18**(3), 317-323.
- Klapchuk M.I.** – See Ivashchyshyn F.O., Grygorchak I.I.; **18**(3), 362-366.
- Kökényesi S.** – See Neimet Yu.Yu., Studenyak I.P., Buchuk M.Yu., Bohdan R., Daróci L., Nemeč P.; **18**(4), 385-390.
- Kökényesi S.** – See Studenyak I.P., Kutsyk M.M., Rati Y.Y., Izai V.Yu., Daróci L., Bohdan R.; **18**(2), 188-192.
- Kolomiets I.S.** – Polarization properties of longitudinally inhomogeneous dichroic medium – Savenkov S.N., Oberemok Ye.A.; **18**(2), 193-199.
- Kolomys O.F.** – See Naumov A.V., Romanyuk A.S., Tsykaniuk B.I., Strelchuk V.V., Trius M.P., Avksentyev A.Yu., Belyaev A.E.; **18**(4), 396-402.
- Kolomys O.F.** – See Strelchuk V.V., Golichenko B.O., Boyko M.I., Kaganovich E.B., Krishchenko I.M., Kravchenko S.O., Lytvyn O.S., Manoilov E.G., Nasieka Iu.M.; **18**(1), 46-52.
- Kolomzarov Yu.V.** – See Grytsenko K.P., Lytvyn P.M., Doroshenko T.P., Bricks J.L., Kurdyukov V., Slominskii Yu.L., Tolmachev O.I.; **18**(4), 433-437.
- Kolyadina E.Yu.** – Analysis of the fundamental absorption edge of the films obtained from the C<sub>60</sub> fullerene molecular beam in vacuum and effect of internal mechanical stresses on it – Matveeva L.A., Neluba P.L., Venger E.F.; **18**(3), 349-353.
- Konakova R.V.** – See Belyaev A.E., Boltovets N.A., Bobyl A.B., Kladko V.P., Kudryk Ya.Ya., Nasyrov M.U., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18**(4), 391-395.
- Konakova R.V.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Slepova A.S.,

- Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18**(3), 317-323.
- Konchitz A.A.** – See Vasin A.V., Ishikawa Y., Rusavsky A.V., Nazarov A.N., Lysenko V.S.; **18**(1), 63-70.
- Kondratenko O.S.** – See Kozachenko V.V., Normand F.Le; **18**(1), 106-109.
- Kondratenko S.V.** – Recombination of charge carriers in heterostructures with Ge nanoislands grown on Si(100); **18**(1), 97-100.
- Kondryuk D.V.** – Temperature changes in the exciton absorption band observed in flat double nanoheterostructures GaAs/Al<sub>x</sub>Ga<sub>1-x</sub>As – Derevyanchuk A.V., Kramar V.M., Kudryavtsev A.A.; **18**(2), 128-133.
- Konin K.P.** – See Karachevtseva L.A., Lytvynenko O.O., Parshyn K.A., Sapelnikova O.Yu., Stronska O.J.; **18**(4), 377-384.
- Konoreva O.V.** – Degradation of electrooptical characteristics of serial GaP light-emitting diodes, caused by fast electrons – Lytovchenko M.V., Malyi Ye.V., Petrenko I.V., Pinkovska M.B., Tartachnyk V.P., Shlapatska V.V.; **18**(3), 312-316.
- Kopčanský P.** – See Studenyak I.P., Demko P.Yu., Bendak A.V., Kovalchuk O.V., Kovalchuk T.M., Lisý V., Timko M., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Lad A.I., Kucheriavchenkova N.M.; **18**(2), 205-208.
- Korbutyak D.V.** – See Kupchak I.M., Serpak N.F., Strelchuk V.V.; **18**(1), 85-89.
- Korchovyi A.A.** – See Dan’ko V.A., Dorozinsky G.V., Indutnyi I.Z., Myn’ko V.I., Ushenin Yu.V., Shepeliavyi P.E., Lukaniuk M.V., Khrystosenko R.V.; **18**(4), 438-442.
- Korchovyi A.A.** – See Shapovalov A.P., Korotash I.V., Rudenko E.M., Sizov F.F., Dubyna D.S., Osipov L.S., Polotskiy D.Yu., Tsybrii Z.F.; **18**(2), 117-122.
- Korkishko R.M.** – See Sachenko A.V., Kostylyov V.P., Kulish M.R., Sokolovskiy I.O., Vlasiuk V.M., Khomenko D.V.; **18**(3), 259-266.
- Kornaga V.I.** – Modeling spectral characteristics for creating smart lighting systems based on RGBW and WW LEDs – Sorokin V.M., Rybalochka A.V., Oliinyk O.S.; **18**(3), 302-308.
- Korotash I.V.** – See Shapovalov A.P., Rudenko E.M., Sizov F.F., Dubyna D.S., Osipov L.S., Polotskiy D.Yu., Tsybrii Z.F., Korchovyi A.A.; **18**(2), 117-122.
- Koroteyev V.V.** – See Syngayivska G.I.; **18**(1), 79-84.
- Koroteyev V.V.** – Theory of high-field electron transport in the heterostructures Al<sub>x</sub>Ga<sub>1-x</sub>As/GaAs/Al<sub>x</sub>Ga<sub>1-x</sub>As with delta-doped barriers. Effect of real-space transfer; **18**(1), 1-11.
- Kostylyov V.P.** – Influence of nanostructured ITO films on surface recombination processes in silicon solar cells – Sachenko A.V., Serba O.A., Slusar T.V., Vlasyuk V.M., Tytarenko P.O., Chernenko V.V.; **18**(4), 464-467.
- Kostylyov V.P.** – See Sachenko A.V., Korkishko R.M., Kulish M.R., Sokolovskiy I.O., Vlasiuk V.M., Khomenko D.V.; **18**(3), 259-266.
- Kotova N.V.** – See Dmitruk N.L., Borkovskaya O.Yu., Mamykin S.V., Havrylenko T.S., Mamontova I.B., Basiuk E.V.; **18**(1), 31-35.
- Kováč F.** – See Azhniuk Yu.M., Gomonnai A.V., Gomonnai O.O., Hasynets S.M., Lopushansky V.V., Petryshynets I., Rubish V.M., Zahn D.R.T.; **18**(3), 248-254.
- Koval G.D.** – See Ushenko A.G., Burkovets D.M., Savich V.O.; **18**(2), 175-180.
- Koval G.D.** – See Ushenko A.G., Dominikov M.M., Lakusta I.I.; **18**(2), 164-169.
- Kovalchuk A.O.** – Analysis of conditions for synthesis of CdS:Mn nanoparticles – Rudko G.Yu., Fediv V.I., Gule E.G.; **18**(1), 74-78.
- Kovalchuk O.V.** – See Studenyak I.P., Demko P.Yu., Bendak A.V., Kovalchuk T.M., Lisý V., Kopčanský P., Timko M., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Lad A.I., Kucheriavchenkova N.M.; **18**(2), 205-208.
- Kovalchuk T.M.** – See Studenyak I.P., Demko P.Yu., Bendak A.V., Kovalchuk O.V., Lisý V., Kopčanský P., Timko M., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Lad A.I., Kucheriavchenkova N.M.; **18**(2), 205-208.
- Kovalenko S.A.** – See Rudko G.Yu., Gule E.G., Bobyk V.V., Solomakha V.M., Bogoslovskaya A.B.; **18**(1), 20-25.
- Kovtonyuk V.M.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18**(3), 317-323.
- Kozachenko V.V.** – Morphology and optical constants of nanographite films created by thermal vacuum deposition – Kondratenko O.S., Normand F.Le; **18**(1), 106-109.
- Kozitskiy S.V.** – See Bacherikov Yu.Yu., Zhuk A.G., Okhrimenko O.B., Kardashov D.L., Kidalov V.V.; **18**(2), 226-229.
- Kozitskiy S.V.** – See Bacherikov Yu.Yu., Zhuk A.G., Okhrimenko O.B., Kardashov D.L.; **18**(3), 309-311.
- Kramar V.M.** – See Kondryuk D.V., Derevyanchuk A.V., Kudryavtsev A.A.; **18**(2), 128-133.

- Kravchenko S.O.** – See Strelchuk V.V., Kolomys O.F., Golichenko B.O., Boyko M.I., Kaganovich E.B., Krishchenko I.M., Lytvyn O.S., Manoilov E.G., Nasieka Iu.M.; **18**(1), 46-52.
- Kravetskiy M.Yu.** – See Pashchenko G.A., Fomin A.V.; **18**(3), 330-332.
- Kravetskiy M.Yu.** – See Stanetska A.S., Tomashyk V.N., Stratiychuk I.B., Tomashyk Z.F., Galkin S.N.; **18**(4), 416-421.
- Krishchenko I.M.** – See Strelchuk V.V., Kolomys O.F., Golichenko B.O., Boyko M.I., Kaganovich E.B., Kravchenko S.O., Lytvyn O.S., Manoilov E.G., Nasieka Iu.M.; **18**(1), 46-52.
- Kuchak A.I.** – See Makhanets O.M., Gutsul V.I., Voitsekhivska O.M.; **18**(1), 57-62.
- Kucheriavchenkova N.M.** – See Studenyak I.P., Demko P.Yu., Bendak A.V., Kovalchuk O.V., Kovalchuk T.M., Lisý V., Kopčanský P., Timko M., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Lad A.I.; **18**(2), 205-208.
- Kudryavtsev A.A.** – See Kondryuk D.V., Derevyanchuk A.V., Kramar V.M.; **18**(2), 128-133.
- Kudryavtsev O.O.** – See Michailovska K.V., Indutnyi I.Z., Sopinsky M.V., Shepeliavii P.E.; **18**(3), 324-329.
- Kudryk Ya.Ya.** – See Belyaev A.E., Boltovets N.A., Bobyl A.B., Kladko V.P., Konakova R.V., Nasrov M.U., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18**(4), 391-395.
- Kudryk Ya.Ya.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18**(3), 317-323.
- Kudryk Ya.Ya.** – See Slipokurov V.S., Dub M.N., Tkachenko A.K.; **18**(2), 144-146.
- Kulish M.R.** – See Sachenko A.V., Kostylyov V.P., Korkishko R.M., Sokolovskiy I.O., Vlasiuk V.M., Khomenko D.V.; **18**(3), 259-266.
- Kupchak I.M.** – Vibrational states of hexagonal ZnO doped with Co – Serpak N.F., Strelchuk V.V., Korbutyak D.V.; **18**(1), 85-89.
- Kurdyukov V.** – See Grytsenko K.P., Lytvyn P.M., Doroshenko T.P., Kolomzarov Yu.V., Bricks J.L., Slominskii Yu.L., Tolmachev O.I.; **18**(4), 433-437.
- Kutsyk M.M.** – See Studenyak I.P., Rati Y.Y., Izai V.Yu., Kökényesi S., Daróci L., Bohdan R.; **18**(2), 188-192.
- Kuzenko V.** – See Dobrovolsky Yu., Pidkamin L.; **18**(4), 443-447.
- Kuznetsov V.M.** – See Myroniuk D.V., Ievtushenko A.I., Lashkarev G.V., Maslyuk V.T.,

Timofeeva I.I., Baturin V.A., Karpenko O.Y., Dranchuk M.V.; **18**(3), 286-291.

## L

- Lad A.I.** – See Studenyak I.P., Demko P.Yu., Bendak A.V., Kovalchuk O.V., Kovalchuk T.M., Lisý V., Kopčanský P., Timko M., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Kucheriavchenkova N.M.; **18**(2), 205-208.
- Lakusta I.I.** – See Ushenko A.G., Dominikov M.M., Koval G.D.; **18**(2), 164-169.
- Lakusta I.I.** – See Ushenko Yu.O., Olar O.I., Novakovska O.Yu.; **18**(2), 181-187.
- Lashkarev G.V.** – See Myroniuk D.V., Ievtushenko A.I., Maslyuk V.T., Timofeeva I.I., Baturin V.A., Karpenko O.Y., Kuznetsov V.M., Dranchuk M.V.; **18**(3), 286-291.
- Lisý V.** – See Studenyak I.P., Demko P.Yu., Bendak A.V., Kovalchuk O.V., Kovalchuk T.M., Kopčanský P., Timko M., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Lad A.I., Kucheriavchenkova N.M.; **18**(2), 205-208.
- Lopatynska O.G.** – Localized surface plasmon resonance in Au nanoprisms on glass substrates – Lopatynskiy A.M., Borodinova T.I., Chegel V.I., Poperenko L.V.; **18**(4), 410-415.
- Lopatynskiy A.M.** – See Chegel V.I., Lytvyn V.K., Shepeliavii P.E., Lytvyn O.S., Goltvyanskyi Yu.V.; **18**(3), 272-278.
- Lopatynskiy A.M.** – See Lopatynska O.G., Borodinova T.I., Chegel V.I., Poperenko L.V.; **18**(4), 410-415.
- Lopushansky V.V.** – See Azhniuk Yu.M., Gomonnai A.V., Gomonnai O.O., Hasynets S.M., Kováč F., Petryshynets I., Rubish V.M., Zahn D.R.T.; **18**(3), 248-254.
- Lukaniuk M.V.** – See Dan'ko V.A., Dorozinsky G.V., Indutnyi I.Z., Myn'ko V.I., Ushenin Yu.V., Shepeliavii P.E., Korchovyi A.A., Khrystosenko R.V.; **18**(4), 438-442.
- Lysenko V.S.** – See Vasin A.V., Ishikawa Y., Rusavsky A.V., Nazarov A.N., Konchitz A.A.; **18**(1), 63-70.
- Lysiuk I.O.** – See Golenkov A.G., Zhuravlev K.S., Gumenjuk-Sichevska J.V., Sizov F.F.; **18**(1), 40-45.
- Lytovchenko M.V.** – See Konoreva O.V., Malyye V., Petrenko I.V., Pinkovska M.B., Tartachnyk V.P., Shlapatska V.V.; **18**(3), 312-316.
- Lytvyn O.S.** – See Chegel V.I., Lytvyn V.K., Lopatynskiy A.M., Shepeliavii P.E., Goltvyanskyi Yu.V.; **18**(3), 272-278.
- Lytvyn O.S.** – See Strelchuk V.V., Kolomys O.F., Golichenko B.O., Boyko M.I., Kaganovich E.B.,

- Krishchenko I.M., Kravchenko S.O.,  
Manoilov E.G., Nasieka Iu.M.; **18**(1), 46-52.
- Lytvyn P.M.** – See Grytsenko K.P., Doroshenko T.P.,  
Kolomzarov Yu.V., Bricks J.L., Kurdyukov V.,  
Slominskii Yu.L., Tolmachev O.I.;  
**18**(4), 433-437.
- Lytvyn V.K.** – See Chegel V.I., Lopatynskiy A.M.,  
Shepeliavyy P.E., Lytvyn O.S.,  
Goltvyanskyi Yu.V.; **18**(3), 272-278.
- Lytvynenko O.O.** – See Karachevtseva L.A.,  
Konin K.P., Parshyn K.A., Sapelnikova O.Yu.,  
Stronska O.J.; **18**(4), 377-384.

## M

- Makhanets O.M.** – Spectral parameters of electron in  
multi-shell open semiconductor nanotube –  
Kuchak A.I., Gutsul V.I., Voitsekhivska O.M.;  
**18**(1), 57-62.
- Malyi Ye.V.** – See Konoreva O.V.,  
Lytovchenko M.V., Petrenko I.V.,  
Pinkovska M.B., Tartachnyk V.P.,  
Shlapatska V.V.; **18**(3), 312-316.
- Mamontova I.B.** – See Dmitruk N.L.,  
Borkovskaya O.Yu., Mamykin S.V.,  
Havrylenko T.S., Kotova N.V., Basiuk E.V.;  
**18**(1), 31-35.
- Mamykin S.V.** – See Dmitruk N.L.,  
Borkovskaya O.Yu., Havrylenko T.S.,  
Mamontova I.B., Kotova N.V., Basiuk E.V.;  
**18**(1), 31-35.
- Manoilov E.G.** – See Strelchuk V.V., Kolomys O.F.,  
Golichenko B.O., Boyko M.I., Kaganovich E.B.,  
Krishchenko I.M., Kravchenko S.O.,  
Lytvyn O.S., Nasieka Iu.M.; **18**(1), 46-52.
- Marchenko L.S.** – See Starchyk M.I.,  
Pinkovska M.B., Shmatko G.G., Varnina V.I.;  
**18**(3), 292-296.
- Markevich I.V.** – About self-activated orange  
emission in ZnO – Stara T.R., Bondarenko V.O.;  
**18**(2), 134-137.
- Markevich I.V.** – Influence of Mg content on defect-  
related luminescence of undoped and doped  
wurtzite MgZnO ceramics – Stara T.R.,  
Bondarenko V.O.; **18**(3), 344-348.
- Maslyuk V.T.** – See Myroniuk D.V., Ievtushenko A.I.,  
Lashkarev G.V., Timofeeva I.I., Baturin V.A.,  
Karpenko O.Y., Kuznetsov V.M.,  
Dranchuk M.V.; **18**(3), 286-291.
- Matveeva L.A.** – See Kolyadina E.Yu., Neluba P.L.,  
Venger E.F.; **18**(3), 349-353.
- Melezhnik E.O.** – Composition and concentration  
dependences of electron mobility in semi-metal  
Hg<sub>1-x</sub>Cd<sub>x</sub>Te quantum wells – Gumenjuk-  
Sichevska J.V., Sizov F.F.; **18**(3), 297-301.
- Melnichuk A.V.** – See Venger E.F.,  
Melnichuk L.Yu., Semikina T.V.;  
**18**(4), 422-427.
- Melnichuk L.Yu.** – See Venger E.F.,  
Melnichuk A.V., Semikina T.V.; **18**(4), 422-427.
- Melnyk R.S.** – See Bratus' V.Ya., Shanina B.D.,  
Okulov S.M.; **18**(4), 403-409.
- Michailovska K.V.** – Polarization memory of the  
luminescence related with Si nanoparticles  
embedded into oxide matrix – Indutnyi I.Z.,  
Kudryavtsev O.O., Sopinskyy M.V.,  
Shepeliavyy P.E.; **18**(3), 324-329.
- Milenin G.V.** – Analysis of random events in  
physical and chemical processes flowing in  
materials of semiconductor products under  
external influences and thermal aging;  
**18**(3), 233-247.
- Milenin G.V.** – Probabilistic approach to the analysis  
of regularities in behavior of parameters inherent  
to materials of electronic equipment under action  
of external fields; **18**(4), 456-459.
- Mishinova G.N.** – See Vlaskina S.I., Vlaskin V.I.,  
Rodionov V.E., Svechnikov G.S.;  
**18**(2), 209-214.
- Mishinova G.N.** – See Vlaskina S.I., Vlaskin V.I.,  
Rodionov V.E., Svechnikov G.S.;  
**18**(4), 448-451.
- Miskuf J.** – See Studenyak I.P., Demko P.Yu.,  
Bendak A.V., Kovalchuk O.V., Kovalchuk T.M.,  
Lisý V., Kopčanský P., Timko M.,  
Tomašovičová N., Zavisova V., Gdovinova V.,  
Oleinikova I.V., Lad A.I.,  
Kucheriavchenkova N.M.; **18**(2), 205-208.
- Motrich A.V.** – See Ushenko Yu.O.,  
Dubolazov O.V., Bodnar G.B.; **18**(2), 158-163.
- Myn'ko V.I.** – See Dan'ko V.A., Dorozinsky G.V.,  
Indutnyi I.Z., Ushenin Yu.V., Shepeliavyy P.E.,  
Lukaniuk M.V., Korchovyy A.A.,  
Khrystosenko R.V.; **18**(4), 438-442.
- Myenko V.I.** – See Sopinskyy M.V., Olkhovik G.P.;  
**18**(4), 460-463.
- Myroniuk D.V.** – Effect of electron irradiation on  
transparent conductive films ZnO:Al deposited  
at different power sputtering – Ievtushenko A.I.,  
Lashkarev G.V., Maslyuk V.T., Timofeeva I.I.,  
Baturin V.A., Karpenko O.Y., Kuznetsov V.M.,  
Dranchuk M.V.; **18**(3), 286-291.

## N

- Nasieka Iu.M.** – See Strelchuk V.V., Kolomys O.F.,  
Golichenko B.O., Boyko M.I., Kaganovich E.B.,  
Krishchenko I.M., Kravchenko S.O.,  
Lytvyn O.S., Manoilov E.G.; **18**(1), 46-52.
- Nasyrov M.U.** – Radiation-stimulated processes in  
silicon structures with contacts based on TiN –  
Ataubaeva A.B.; **18**(2), 220-225.
- Nasyrov M.U.** – See Belyaev A.E., Boltovets N.A.,  
Bobyly A.B., Kladko V.P., Konakova R.V.,  
Kudryk Ya.Ya., Sachenko A.V.,  
Slipokurov V.S., Slepova A.S., Safryuk N.V.,

- Gudymenko A.I., Shynkarenko V.V.; **18(4)**, 391-395.
- Naumov A.V.** – Self-heating effects in AlGaIn/GaN HEMT heterostructures: Electrical and optical characterization – Kolomys O.F., Romanyuk A.S., Tsykaniuk B.I., Strelchuk V.V., Trius M.P., Avksentyev A.Yu., Belyaev A.E.; **18(4)**, 396-402.
- Nazarov A.N.** – See Vasin A.V., Ishikawa Y., Rusavsky A.V., Konchitz A.A., Lysenko V.S.; **18(1)**, 63-70.
- Neimet Yu.Yu.** – Photo-induced effects in  $(\text{Ag}_3\text{AsS}_3)_{0.6}(\text{As}_2\text{S}_3)_{0.4}$  thin films and multilayers with gold nanoparticles – Studenyak I.P., Buchuk M.Yu., Bohdan R., Kökényesi S., Daróci L., Nemeč P.; **18(4)**, 385-390.
- Neluba P.L.** – See Kolyadina E.Yu., Matveeva L.A., Venger E.F.; **18(3)**, 349-353.
- Nemeč P.** – See Neimet Yu.Yu., Studenyak I.P., Buchuk M.Yu., Bohdan R., Kökényesi S., Daróci L.; **18(4)**, 385-390.
- Normand F.Le** – See Kozachenko V.V., Kondratenko O.S.; **18(1)**, 106-109.
- Novakovska O.Yu.** – See Ushenko Yu.O., Lakusta I.I., Olar O.I.; **18(2)**, 181-187.

## O

- Oberemok Ye.A.** – See Kolomiets I.S., Savenkov S.N.; **18(2)**, 193-199.
- Okhrimenko O.B.** – Phenomenological model of athermal interaction of microwave radiation with the structures wide-gap semiconductor – oxide film; **18(4)**, 452-455.
- Okhrimenko O.B.** – See Bacherikov Yu.Yu., Zhuk A.G., Kardashov D.L., Kozitskiy S.V., Kidalov V.V.; **18(2)**, 226-229.
- Okhrimenko O.B.** – See Bacherikov Yu.Yu., Zhuk A.G., Kardashov D.L., Kozitskiy S.V.; **18(3)**, 309-311.
- Okulov S.M.** – See Bratus' V.Ya., Melnyk R.S., Shanina B.D.; **18(4)**, 403-409.
- Olar O.I.** – See Dubolazov O.V., Burkovets D.M.; **18(2)**, 170-174.
- Olar O.I.** – See Ushenko Yu.O., Lakusta I.I., Novakovska O.Yu.; **18(2)**, 181-187.
- Oleinikova I.V.** – See Studenyak I.P., Demko P.Yu., Bendak A.V., Kovalchuk O.V., Kovalchuk T.M., Lisý V., Kopčanský P., Timko M., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Lad A.I., Kucheriavchenkova N.M.; **18(2)**, 205-208.
- Oleksenko P.F.** – See Khmil D.N., Kamuz A.M., Kamuz V.G., Aleksenko N.G., Kamuz O.A.; **18(2)**, 215-219.
- Oleksenko P.F.** – See Khmil' D.N., Kamuz A.M., Kamuz V.G., Aleksenko N.G., Kamuz O.A.; **18(3)**, 333-340.
- Oliinyk O.S.** – See Kornaga V.I., Sorokin V.M., Rybalochka A.V.; **18(3)**, 302-308.
- Olkhovik G.P.** – See Sopinsky M.V., Mynko V.I.; **18(4)**, 460-463.
- Onachenko Marat** – Superluminescent laser-integrated nanocarbonized matrix pumping of neodymium lasers YAG:Nd; **18(3)**, 367-371.
- Osipov L.S.** – See Shapovalov A.P., Korotash I.V., Rudenko E.M., Sizov F.F., Dubyna D.S., Polotskiy D.Yu., Tsybrii Z.F., Korchovy A.A.; **18(2)**, 117-122.

## P

- Parashchuk V.V.** – See Rusakov K.I.; **18(1)**, 36-39.
- Parshyn K.A.** – See Karachevtseva L.A., Lytvynenko O.O., Konin K.P., Sapelnikova O.Yu., Stronska O.J.; **18(4)**, 377-384.
- Pashchenko G.A.** – Modeling the process of removal aimed at cut traces on semiconductor wafers by using the method of contactless chemical-and-dynamical polishing – Kravetskiy M.Yu., Fomin A.V.; **18(3)**, 330-332.
- Pavelets S.Yu.** – See Bobrenko Yu.N., Semikina T.V., Stadnyk O.A., Sheremetova G.I., Yaroshenko M.V.; **18(1)**, 101-105.
- Petrenko I.V.** – See Konoreva O.V., Lytovchenko M.V., Malyi Ye.V., Pinkovska M.B., Tartachnyk V.P., Shlapatska V.V.; **18(3)**, 312-316.
- Petryshynets I.** – See Azhniuk Yu.M., Gomonnai A.V., Gomonnai O.O., Hasynets S.M., Kováč F., Lopushansky V.V., Rubish V.M., Zahn D.R.T.; **18(3)**, 248-254.
- Pidkamin L.** – See Dobrovolsky Yu., Kuzenko V.; **18(4)**, 443-447.
- Pinkovska M.B.** – See Konoreva O.V., Lytovchenko M.V., Malyi Ye.V., Petrenko I.V., Tartachnyk V.P., Shlapatska V.V.; **18(3)**, 312-316.
- Pinkovska M.B.** – See Starchyk M.I., Marchenko L.S., Shmatko G.G., Varnina V.I.; **18(3)**, 292-296.
- Piskovoi V.N.** – See Venger E.F.; **18(3)**, 255-258.
- Polotskiy D.Yu.** – See Shapovalov A.P., Korotash I.V., Rudenko E.M., Sizov F.F., Dubyna D.S., Osipov L.S., Tsybrii Z.F., Korchovy A.A.; **18(2)**, 117-122.
- Poperenko L.V.** – See Lopatynska O.G., Lopatynskyi A.M., Borodinova T.I., Chegel V.I.; **18(4)**, 410-415.
- Poperenko L.V.** – See Rozouvan T.S., Shaykevich I.A.; **18(1)**, 26-30.
- Prysyazhnyuk V.P.** – See Sidor M.I., Karachevtsev A.O.; **18(2)**, 147-151.

## R

- Rati Y.Y.** – See Studenyak I.P., Kutsyk M.M., Izai V.Yu., Kökényesi S., Daróci L., Bohdan R.; **18(2)**, 188-192.
- Red'ko S.M.** – Influence of treatment in weak magnetic fields on photoluminescence of GaN:Si; **18(1)**, 71-73.
- Rodionov V.E.** – See Vlaskina S.I., Mishinova G.N., Vlaskin V.I., Svechnikov G.S.; **18(2)**, 209-214.
- Rodionov V.E.** – See Vlaskina S.I., Mishinova G.N., Vlaskin V.I., Svechnikov G.S.; **18(4)**, 448-451.
- Romanyuk A.S.** – See Naumov A.V., Kolomys O.F., Tsykaniuk B.I., Strelchuk V.V., Trius M.P., Avksentyev A.Yu., Belyaev A.E.; **18(4)**, 396-402.
- Romanyuk Yu.A.** – See Yaremko A.M., Yukhymchuk V.O., Virko S.V.; **18(3)**, 354-361.
- Rozouvan T.S.** – Influence of the surface roughness and oxide surface layer onto Si optical constants measured by the ellipsometry technique – Poperenko L.V., Shaykevich I.A.; **18(1)**, 26-30.
- Rubish V.M.** – See Azhniuk Yu.M., Gomonnai A.V., Gomonnai O.O., Hasynets S.M., Kováč F., Lopushansky V.V., Petryshynets I., Zahn D.R.T.; **18(3)**, 248-254.
- Rudenko E.M.** – See Shapovalov A.P., Korotash I.V., Sizov F.F., Dubyna D.S., Osipov L.S., Polotskiy D.Yu., Tsybrii Z.F., Korchovyi A.A.; **18(2)**, 117-122.
- Rudko G.Yu.** – See Kovalchuk A.O., Fediv V.I., Gule E.G.; **18(1)**, 74-78.
- Rudko G.Yu.** – Zinc oxide nanoparticles fabricated in the porous silica matrix by the sublimation method – Kovalenko S.A., Gule E.G., Bobyk V.V., Solomakha V.M., Bogoslovskaya A.B.; **18(1)**, 20-25.
- Rusakov K.I.** – Nonlinear-optical processes at streamer discharge in semiconductors – Parashchuk V.V.; **18(1)**, 36-39.
- Rusavsky A.V.** – See Vasin A.V., Ishikawa Y., Nazarov A.N., Konchitz A.A., Lysenko V.S.; **18(1)**, 63-70.
- Rybalochka A.V.** – See Kornaga V.I., Sorokin V.M., Oliinik O.S.; **18(3)**, 302-308.

## S

- Sachenko A.V.** – Peculiarities of the temperature dependences of silicon solar cells illuminated with light simulator – Kostylyov V.P., Korkishko R.M., Kulish M.R., Sokolovskiy I.O., Vlasiuk V.M., Khomenko D.V.; **18(3)**, 259-266.
- Sachenko A.V.** – See Belyaev A.E., Boltovets N.A., Bobyl A.B., Kladko V.P., Konakova R.V., Kudryk Ya.Ya., Nasyrov M.U., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(4)**, 391-395.
- Sachenko A.V.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(3)**, 317-323.
- Sachenko A.V.** – See Kostylyov V.P., Serba O.A., Slusar T.V., Vlasyuk V.M., Tytarenko P.O., Chernenko V.V.; **18(4)**, 464-467.
- Safryuk N.V.** – See Belyaev A.E., Boltovets N.A., Bobyl A.B., Kladko V.P., Konakova R.V., Kudryk Ya.Ya., Nasyrov M.U., Sachenko A.V., Slipokurov V.S., Slepova A.S., Gudymenko A.I., Shynkarenko V.V.; **18(4)**, 391-395.
- Safryuk N.V.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Slepova A.S., Gudymenko A.I., Shynkarenko V.V.; **18(3)**, 317-323.
- Sapelnikova O.Yu.** – See Karachevtseva L.A., Lytvynenko O.O., Konin K.P., Parshyn K.A., Stronska O.J.; **18(4)**, 377-384.
- Savenkov S.N.** – See Kolomiets I.S., Oberemok Ye.A.; **18(2)**, 193-199.
- Savich V.O.** – See Ushenko A.G., Koval G.D., Burkovets D.M.; **18(2)**, 175-180.
- Semikina T.V.** – See Bobrenko Yu.N., Pavelets S.Yu., Stadnyk O.A., Sheremetova G.I., Yaroshenko M.V.; **18(1)**, 101-105.
- Semikina T.V.** – See Venger E.F., Melnichuk L.Yu., Melnichuk A.V.; **18(4)**, 422-427.
- Serba O.A.** – See Kostylyov V.P., Sachenko A.V., Slusar T.V., Vlasyuk V.M., Tytarenko P.O., Chernenko V.V.; **18(4)**, 464-467.
- Serpak N.F.** – See Kupchak I.M., Strelchuk V.V., Korbutyak D.V.; **18(1)**, 85-89.
- Shanina B.D.** – See Bratus' V.Ya., Melnyk R.S., Okulov S.M.; **18(4)**, 403-409.
- Shapovalov A.P.** – Structure and optical properties of AlN films obtained using the cathodic arc plasma deposition technique – Korotash I.V., Rudenko E.M., Sizov F.F., Dubyna D.S., Osipov L.S., Polotskiy D.Yu., Tsybrii Z.F., Korchovyi A.A.; **18(2)**, 117-122.
- Shaykevich I.A.** – See Rozouvan T.S., Poperenko L.V.; **18(1)**, 26-30.
- Shepeliavyi P.E.** – See Chegel V.I., Lytvyn V.K., Lopatynskiy A.M., Lytvyn O.S., Goltvyanskyi Yu.V.; **18(3)**, 272-278.
- Shepeliavyi P.E.** – See Dan'ko V.A., Dorozinsky G.V., Indutnyi I.Z., Myn'ko V.I., Ushenin Yu.V., Lukaniuk M.V., Korchovyi A.A., Khrystosenko R.V.; **18(4)**, 438-442.
- Shepeliavyi P.E.** – See Michailovska K.V., Indutnyi I.Z., Kudryavtsev O.O., Sopinsky M.V.; **18(3)**, 324-329.
- Sheremetova G.I.** – See Bobrenko Yu.N., Pavelets S.Yu., Semikina T.V., Stadnyk O.A., Yaroshenko M.V.; **18(1)**, 101-105.

- Shevchik-Shekera A.V.** – Design of optical components for terahertz/sub-terahertz imaging systems – Dukhnin S.E.; **18(3)**, 341-343.
- Shlapatska V.V.** – See Konoreva O.V., Lytovchenko M.V., Maliy Ye.V., Petrenko I.V., Pinkovska M.B., Tartachnyk V.P.; **18(3)**, 312-316.
- Shmatko G.G.** – See Starchyk M.I., Marchenko L.S., Pinkovska M.B., Varnina V.I.; **18(3)**, 292-296.
- Shpotyuk M.V.** – On the origin of radiation-induced metastability in vitreous chalcogenide semiconductors: The role of intrinsic and impurity-related destruction-polymerization transformations – Vakiv M.M., Shpotyuk O.I., Ubizskii S.B.; **18(1)**, 90-96.
- Shpotyuk O.I.** – See Shpotyuk M.V., Vakiv M.M., Ubizskii S.B.; **18(1)**, 90-96.
- Shynkarenko V.V.** – Development of modeling methods and algorithm for calculating the current-voltage characteristics of LED modules; **18(2)**, 200-204.
- Shynkarenko V.V.** – See Belyaev A.E., Boltovets N.A., Bobyl A.B., Kladko V.P., Konakova R.V., Kudryk Ya.Ya., Nasyrov M.U., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I.; **18(4)**, 391-395.
- Shynkarenko V.V.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Slepova A.S., Safryuk N.V., Gudymenko A.I.; **18(3)**, 317-323.
- Sidor M.I.** – Azimuthally invariant phase tomography of optically anisotropic sections of biological tissues – Karachevtsev A.O., Prisyazhnyuk V.P.; **18(2)**, 147-151.
- Sidor M.I.** – See Dubolazov O.V., Karachevtsev A.O.; **18(2)**, 152-157.
- Sizov F.F.** – See Golenkov A.G., Zhuravlev K.S., Gumenjuk-Sichevska J.V., Lysiuk I.O.; **18(1)**, 40-45.
- Sizov F.F.** – See Melezhhik E.O., Gumenjuk-Sichevska J.V.; **18(3)**, 297-301.
- Sizov F.F.** – See Shapovalov A.P., Korotash I.V., Rudenko E.M., Dubyna D.S., Osipov L.S., Polotskiy D.Yu., Tsybrii Z.F., Korchovy A.A.; **18(2)**, 117-122.
- Slepova A.S.** – See Belyaev A.E., Boltovets N.A., Bobyl A.B., Kladko V.P., Konakova R.V., Kudryk Ya.Ya., Nasyrov M.U., Sachenko A.V., Slipokurov V.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(4)**, 391-395.
- Slepova A.S.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slipokurov V.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(3)**, 317-323.
- Slipokurov V.S.** – Methodological aspects of measuring the resistivity of contacts to high-resistance semiconductors – Dub M.N., Tkachenko A.K., Kudryk Ya.Ya.; **18(2)**, 144-146.
- Slipokurov V.S.** – See Belyaev A.E., Boltovets N.A., Bobyl A.B., Kladko V.P., Konakova R.V., Kudryk Ya.Ya., Nasyrov M.U., Sachenko A.V., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(4)**, 391-395.
- Slipokurov V.S.** – See Belyaev A.E., Boltovets N.S., Bobyl A.V., Zorenko A.V., Arsentiev I.N., Kladko V.P., Kovtonyuk V.M., Konakova R.V., Kudryk Ya.Ya., Sachenko A.V., Slepova A.S., Safryuk N.V., Gudymenko A.I., Shynkarenko V.V.; **18(3)**, 317-323.
- Slominskii Yu.L.** – See Grytsenko K.P., Lytvyn P.M., Doroshenko T.P., Kolomzarov Yu.V., Bricks J.L., Kurdyukov V., Tolmachev O.I.; **18(4)**, 433-437.
- Slusar T.V.** – See Kostylyov V.P., Sachenko A.V., Serba O.A., Vlasyuk V.M., Tytarenko P.O., Chernenko V.V.; **18(4)**, 464-467.
- Sokolovskiy I.O.** – See Sachenko A.V., Kostylyov V.P., Korkishko R.M., Kulish M.R., Vlasiuk V.M., Khomenko D.V.; **18(3)**, 259-266.
- Solomakha V.M.** – See Rudko G.Yu., Kovalenko S.A., Gule E.G., Bobyk V.V., Bogoslovskaya A.B.; **18(1)**, 20-25.
- Sopinskyy M.V.** – Long wavelength light sensitivity of thin film system based on PbI<sub>2</sub> and Cu – Mynko V.I., Olkhovik G.P.; **18(4)**, 460-463.
- Sopinskyy M.V.** – See Michailovska K.V., Indutnyi I.Z., Kudryavtsev O.O., Shepeliavyi P.E.; **18(3)**, 324-329.
- Sorokin V.M.** – See Kornaga V.I., Rybalochka A.V., Oliinyk O.S.; **18(3)**, 302-308.
- Stadnyk O.A.** – See Bobrenko Yu.N., Pavelets S.Yu., Semikina T.V., Sheremetova G.I., Yaroshenko M.V.; **18(1)**, 101-105.
- Stanetska A.S.** – Development, optimization and improvement of ZnSe crystal surfaces mechanical and chemical treatment and washing methods – Tomashyk V.N., Stratiychuk I.B., Tomashyk Z.F., Kravetsky M.Yu., Galkin S.N.; **18(4)**, 416-421.
- Stara T.R.** – See Markevich I.V., Bondarenko V.O.; **18(2)**, 134-137.
- Stara T.R.** – See Markevich I.V., Bondarenko V.O.; **18(3)**, 344-348.
- Starchyk M.I.** – Voids' layer structures in silicon irradiated with high doses of high-energy helium ions – Marchenko L.S., Pinkovska M.B., Shmatko G.G., Varnina V.I.; **18(3)**, 292-296.
- Stratiychuk I.B.** – See Stanetska A.S., Tomashyk V.N., Tomashyk Z.F., Kravetsky M.Yu., Galkin S.N.; **18(4)**, 416-421.
- Strelchuk V.V.** – Micro-Raman study of nanocomposite porous films with silver

nanoparticles prepared using pulsed laser deposition – Kolomys O.F., Golichenko B.O., Boyko M.I., Kaganovich E.B., Krishchenko I.M., Kravchenko S.O., Lytvyn O.S., Manoilov E.G., Nasieka Iu.M.; **18**(1), 46-52.

**Strelchuk V.V.** – See Kupchak I.M., Serpak N.F., Korbutyak D.V.; **18**(1), 85-89.

**Strelchuk V.V.** – See Naumov A.V., Kolomys O.F., Romanyuk A.S., Tsykaniuk B.I., Trius M.P., Avksentyev A.Yu., Belyaev A.E.; **18**(4), 396-402.

**Stronska O.J.** – See Karachevtseva L.A., Lytvynenko O.O., Konin K.P., Parshyn K.A., Sapelnikova O.Yu.; **18**(4), 377-384.

**Studeniyak I.P.** – Influence of superionic nanoparticles Cu<sub>6</sub>PS<sub>5</sub>I on dielectric properties of nematic liquid crystal 6CHBT – Demko P.Yu., Bendak A.V., Kovalchuk O.V., Kovalchuk T.M., Lisý V., Kopčanský P., Timko M., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Lad A.I., Kucheriavchenkova N.M.; **18**(2), 205-208.

**Studeniyak I.P.** – See Neimet Yu.Yu., Buchuk M.Yu., Bohdan R., Kökényesi S., Daróci L., Nemeč P.; **18**(4), 385-390.

**Studeniyak I.P.** – Temperature studies of optical parameters in (Ag<sub>3</sub>AsS<sub>3</sub>)<sub>0.6</sub>(As<sub>2</sub>S<sub>3</sub>)<sub>0.4</sub> thin films – Kutsyk M.M., Rati Y.Y., Izai V.Yu., Kökényesi S., Daróci L., Bohdan R.; **18**(2), 188-192.

**Sukach A.V.** – Carrier transport mechanisms in reverse biased InSb p-n junctions – Tetyorkin V.V., Tkachuk A.I.; **18**(3), 267-271.

**Sukach A.V.** – See Tetyorkin V.V., Boiko V.A., Tkachuk A.I.; **18**(4), 428-432.

**Svechnikov G.S.** – See Vlaskina S.I., Mishinova G.N., Vlaskin V.I., Rodionov V.E.; **18**(2), 209-214.

**Svechnikov G.S.** – See Vlaskina S.I., Mishinova G.N., Vlaskin V.I., Rodionov V.E.; **18**(4), 448-451.

**Syngayivska G.I.** – Electron transport in crossed electric and magnetic fields under the condition of the electron streaming in GaN – Korotyeyev V.V.; **18**(1), 79-84.

## T

**Tartachnyk V.P.** – See Konoreva O.V., Lytovchenko M.V., Malýi Ye.V., Petrenko I.V., Pinkovska M.B., Shlapatska V.V.; **18**(3), 312-316.

**Tetyorkin V.V.** – Characterization of grain boundaries in CdTe polycrystalline films – Sukach A.V., Boiko V.A., Tkachuk A.I.; **18**(4), 428-432.

**Tetyorkin V.V.** – See Sukach A.V., Tkachuk A.I.; **18**(3), 267-271.

**Timko M.** – See Studeniyak I.P., Demko P.Yu., Bendak A.V., Kovalchuk O.V., Kovalchuk T.M., Lisý V., Kopčanský P., Tomašovičová N., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Lad A.I., Kucheriavchenkova N.M.; **18**(2), 205-208.

**Timofeeva I.I.** – See Myroniuk D.V., Ievtushenko A.I., Lashkarev G.V., Maslyuk V.T., Baturin V.A., Karpenko O.Y., Kuznetsov V.M., Dranchuk M.V.; **18**(3), 286-291.

**Tkachenko A.K.** – See Slipokurov V.S., Dub M.N., Kudryk Ya.Ya.; **18**(2), 144-146.

**Tkachuk A.I.** – See Sukach A.V., Tetyorkin V.V.; **18**(3), 267-271.

**Tkachuk A.I.** – See Tetyorkin V.V., Sukach A.V., Boiko V.A.; **18**(4), 428-432.

**Tolmachev O.I.** – See Grytsenko K.P., Lytvyn P.M., Doroshenko T.P., Kolomzarov Yu.V., Bricks J.L., Kurdyukov V., Slominskii Yu.L.; **18**(4), 433-437.

**Tomashyk V.N.** – See Stanetska A.S., Stratiychuk I.B., Tomashyk Z.F., Kravetsky M.Yu., Galkin S.N.; **18**(4), 416-421.

**Tomashyk Z.F.** – See Stanetska A.S., Tomashyk V.N., Stratiychuk I.B., Kravetsky M.Yu., Galkin S.N.; **18**(4), 416-421.

**Tomašovičová N.** – See Studeniyak I.P., Demko P.Yu., Bendak A.V., Kovalchuk O.V., Kovalchuk T.M., Lisý V., Kopčanský P., Timko M., Zavisova V., Gdovinova V., Miskuf J., Oleinikova I.V., Lad A.I., Kucheriavchenkova N.M.; **18**(2), 205-208.

**Trius M.P.** – See Naumov A.V., Kolomys O.F., Romanyuk A.S., Tsykaniuk B.I., Strelchuk V.V., Avksentyev A.Yu., Belyaev A.E.; **18**(4), 396-402.

**Tsybrii Z.F.** – See Shapovalov A.P., Korotash I.V., Rudenko E.M., Sizov F.F., Dubyna D.S., Osipov L.S., Polotskiy D.Yu., Korchovi A.A.; **18**(2), 117-122.

**Tsykaniuk B.I.** – See Naumov A.V., Kolomys O.F., Romanyuk A.S., Strelchuk V.V., Trius M.P., Avksentyev A.Yu., Belyaev A.E.; **18**(4), 396-402.

**Tytarenko P.O.** – See Kostylyov V.P., Sachenko A.V., Serba O.A., Slusar T.V., Vlasyuk V.M., Chernenko V.V.; **18**(4), 464-467.

## U

**Ubizskii S.B.** – See Shpotyuk M.V., Vakiv M.M., Shpotyuk O.I.; **18**(1), 90-96.

**Ushenin Yu.V.** – See Dan'ko V.A., Dorozinsky G.V., Indutnyi I.Z., Myn'ko V.I., Shepeliavyy P.E., Lukaniuk M.V., Korchovi A.A., Khrystosenko R.V.; **18**(4), 438-442.

- Ushenko A.G.** – Autofluorescent polarimetry in diagnostics of endometriosis and infertility – Koval G.D., Burkovets D.M., Savich V.O.; **18(2)**, 175-180.
- Ushenko A.G.** – Mueller-matrix reconstruction of parameters of phase and amplitude anisotropy in diagnostics of endometriosis and infertility – Dominikov M.M., Lakusta I.I., Koval G.D.; **18(2)**, 164-169.
- Ushenko Yu.O.** – Azimuthally invariant laser polarimetry of polycrystalline smears of biological liquids – Dubolazov O.V., Motrich A.V., Bodnar G.B.; **18(2)**, 158-163.
- Ushenko Yu.O.** – Fluorescent Mueller-matrix polarimetry of biological tissues in differentiation of benign and malignant tumors – Lakusta I.I., Olar O.I., Novakovska O.Yu.; **18(2)**, 181-187.

## V

- Vakiv M.M.** – See Shpotyuk M.V., Shpotyuk O.I., Ubizskii S.B.; **18(1)**, 90-96.
- Varnina V.I.** – See Starchyk M.I., Marchenko L.S., Pinkovska M.B., Shmatko G.G.; **18(3)**, 292-296.
- Vasin A.V.** – Photoluminescent properties of oxidized stoichiometric and carbon-rich amorphous  $\text{Si}_{1-x}\text{C}_x\text{:H}$  films – Ishikawa Y., Rusavsky A.V., Nazarov A.N., Konchitz A.A., Lysenko V.S.; **18(1)**, 63-70.
- Venger E.F.** – On the dielectric approximation in the additional light waves theory: an historical rehabilitation (recovery) – Piskovoi V.N.; **18(3)**, 255-258.
- Venger E.F.** – See Kolyadina E.Yu., Matveeva L.A., Neluba P.L.; **18(3)**, 349-353.
- Venger E.F.** – Surface polariton excitation in ZnO films deposited using ALD – Melnichuk L.Yu., Melnichuk A.V., Semikina T.V.; **18(4)**, 422-427.
- Vertsimakha G.V.** – Peculiarities of exciton scattering in double semiconductor quantum wells with disordered layers; **18(1)**, 110-114.
- Virko S.V.** – See Yaremko A.M., Yukhymchuk V.O., Romanyuk Yu.A.; **18(3)**, 354-361.
- Vlasiuk V.M.** – See Sachenko A.V., Kostylyov V.P., Korkishko R.M., Kulish M.R., Sokolovskiy I.O., Khomenko D.V.; **18(3)**, 259-266.
- Vlaskin V.I.** – See Vlaskina S.I., Mishinova G.N., Rodionov V.E., Svechnikov G.S.; **18(2)**, 209-214.
- Vlaskin V.I.** – See Vlaskina S.I., Mishinova G.N., Rodionov V.E., Svechnikov G.S.; **18(4)**, 448-451.
- Vlaskina S.I.** – External impacts on SiC nanostructures in pure and lightly doped silicon carbide crystals – Mishinova G.N., Vlaskin V.I., Rodionov V.E., Svechnikov G.S.; **18(4)**, 448-451.
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